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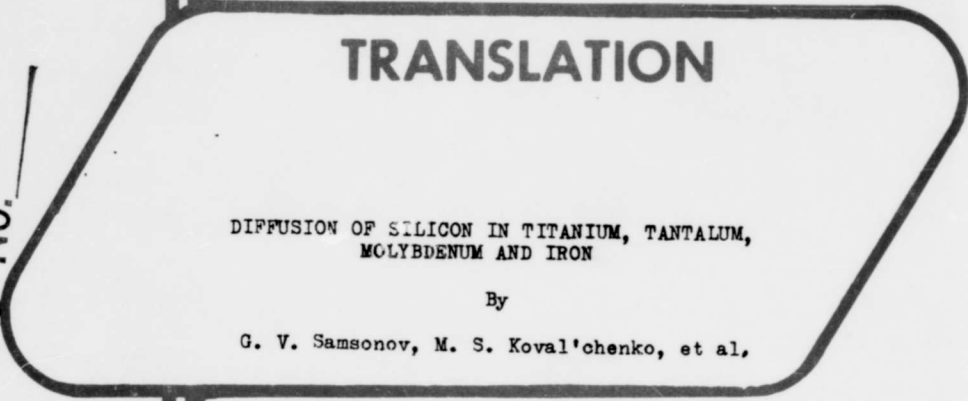
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# TRANSLATION

DIFFUSION OF SILICON IN TITANIUM, TANTALUM,  
MOLYBDENUM AND IRON

By

G. V. Samsonov, M. S. Koval'chenko, et al.

## FOREIGN TECHNOLOGY DIVISION

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BY: G. V. Samsonov, M. S. Koval'chenko, et al.

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DIFFUSION OF SILICON IN TITANIUM, TANTALUM, MOLYBDENUM AND IRON

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The formation on the surface of metals of solid silicide coatings, which are highly resistant to acids, molten salts and certain metals, have high heat resistance and antithermoemission properties, surface saturation by silicon is of great interest for modern technology [1 - 4].

The obtainment of silicide coatings by deposition of silicon from gaseous phase on metals of IV-VI groups of the periodical system is described in report [5], iron and steel - in [6]. In report [7] was made the first effort to explain the nature of phases, which will be formed during the saturation of high melting silicon metals.

In the given investigation the authors are trying to make a more thorough investigation of silicon diffusion in titanium, tantalum, molybdenum and iron. Investigation were made on samples of titanium (99.98%), tantalum (99.6% Ta; 0.4% Nb), molybdenum (99.98%), iron (armko-iron) with the utilization of silicon, purified by the method, described in report [8]. The samples were saturated with silicon in an Argon atmosphere from a solid phase bath, which consisted of 97% Si and 3%  $\text{NH}_4\text{Cl}$ . Ammonium chloride was introduced into the batch for which, in order that a certain amount of  $\text{SiCl}_4$  should be formed between it and the silicon during reaction, which during the decomposition on the surface of the metal with separation of active silicon accelerates the process of diffusion, and HCl vapors, which form in this case, pickle the metal and promote diffusion.

The titanium, tantalum, molybdenum and iron samples were saturated with silicon at temperatures of 600-1200° with a 100° interval, for a period of 4 years with the

exception, that the time of saturation varied at temperatures of 900, 1000 and 1200° respectively for titanium and iron, molybdenum and tantalum.

The relative change in weight, diameter and height of samples depending upon temperature and time of saturation can be described by empirical equations

$$\frac{\Delta p}{p} = \sqrt{A} \cdot e^{-\frac{B}{T}} \quad (1)$$

where  $\frac{\Delta p}{p}$  - relative change in weight, diameter or height;  $\gamma$  - time of saturation;  $T$  - absolute temperature; A, B - experimentally designated constants.

Metallographic and x-ray investigations as well as microhardness measurements revealed that during diffusion of silicon in titanium, tantalum, molybdenum and iron, at low temperatures are formed monophase silicide layers, and at higher temperatures (1000-1200°) two phase layer do originate.

Results of measuring layer thickness, phase composition of layers and microhardness at a distance of 20 microns from the outer surface of samples are listed in table.

It has been established on the basis of results in determining the force of piercing silicide coatings [9], that it increases with the increases in silicide layer thicknesses. But electric resistance and piercing strain are to a considerable extent affected by phase composition of the layer, porosity and degree of being separated from the metal base. An increase in the content of silicon in the layer, as a rule, leads to a sharp rise in piercing stress. Piercing stress at identical thickness of silicide layer for various metals is also different (table).

As is evident from the mentioned data, piercing stress rises at a reduction in the degree of defectiveness of unfilled d-sub levels of atoms of transition metals.

Considering the predominant formations during silicon saturation of TiSi, TaSi<sub>2</sub>, Mo<sub>3</sub>Si<sub>2</sub> and FeSi phases, we have determined the diffusion coefficients by the method, described in [10], and the values of activation energy, listed in table. The temperature dependence graph of the diffusion coefficients are presented in drawing.

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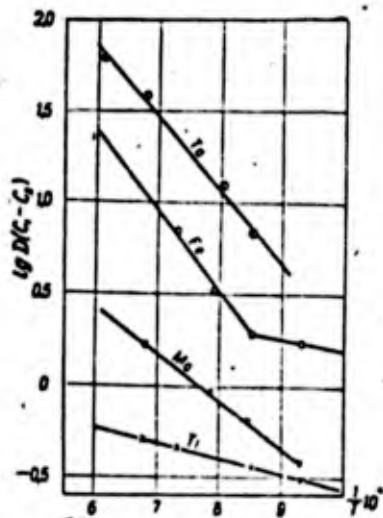


Fig. Temperature dependence of diffusion phases in silicide layers on iron and molybdenum and coefficient of silicon in titanium, tantalum, molybdenum and iron.

and melting points of these compounds [12].

In the Fe-Si system to the FeSi compound corresponds a maximum revealed in the liquidus curve and the melting point exceeds the melting point of other iron/silicon compounds. The higher heat of formation of this phase is due to their predominant content in the composition of silicide coatings on iron.

Analogous phenomena are observed during the formation of Mo<sub>3</sub>Si<sub>2</sub>.

The previously made statement on the effect of purely electron factors on the diffusion of metalloids in metals [7] has been confirmed in this report.

#### Literature

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It is evident from the results of this investigation, that during diffusion saturation of transition metals with silicon are formed silicide coatings, whereby disilicide phases are not always predominant in the layers, in spite of the fact, as shown by [7], that they may always be formed. The TiSi compounds formed predominantly on titanium correspond to literature data for maximum temperature of formation of this silicide as compared with Ti<sub>5</sub>Si<sub>3</sub> and TiSi<sub>2</sub> silicides [11].

Formations of FeSi and Mo<sub>3</sub>Si<sub>2</sub>, as basic

lybdenum, apparently, take place in accordance

Table: Thickness, Phase Composition, Microhardness, Piercing Stress of Diffusion Coatings and Magnitude of Diffusion Constants.

1. Metal
2.  $\frac{11}{Nn}$
3. Temp. °C
4. Hour - Year
5. Layer thickness  $\mu$
6. Phase comp.
7. Micro hardness at distance of  $20\mu$  from surf. of sample kg/mm<sup>2</sup>
8. Piercing stress  $\sigma$
9. Activation energy  $a$ , designated analytically cal/mol
10.  $D_0$ , cm<sup>2</sup>/sec
11. Equations of temperature dependence of diffusion coefficient.
12. Titanium
13. Tantalum
14. Molybdenum
15. Iron

1.	2.	3.	4.	5.	6.	7.	8.	9.	10.	11.
Метал	$\frac{11}{Nn}$	Темп. °C	Час, год.	Товщина шару, $\mu$	Фазовий склад	Мікротвердість на відстані 20 $\mu$ від поверхні, кг/мм <sup>2</sup>	Напруга проборої, $\sigma$	Енергія активації $a$ , виражена аналітично, кал/моль	$D_0$ , см <sup>2</sup> /сек	Рівняння температурної залежності коефіцієнта дифузії
12. Титан	0,167	80	1	other grains	TiSi <sub>2</sub> , TiSi <sub>3</sub> TiSi <sub>2</sub> , TiSi <sub>3</sub> TiSi <sub>2</sub> , TiSi <sub>3</sub> TiSi <sub>2</sub> , TiSi <sub>3</sub>	1000	1,2	3216,4 - 2367,0	2,99	$D = 2,99 \frac{-2002 - 1810,2}{T}$
		90	4	40		1200				
		100	4	50		1640				
		1000	4	55		1220				
13. Тантал	0,063	1100	4	70	TiSi <sub>2</sub> , TiSi <sub>3</sub>	1000	1,8	21513,2 - 1671,0	36,23 · 10 <sup>3</sup>	$D = 36,23 \cdot 10^3 \frac{-10266,5 \cdot K}{T}$
		1200	4	70	1260					
		1200	4	70	1260					
		1200	4	70	1260					
14. Молибден	0,50	80	4	40	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1320	4,2	13387,5 - 8416,9	1,5 · 10 <sup>3</sup>	$D = 1,5 \cdot 10^3 \frac{-9237 - 4200 \cdot K}{T}$
		90	4	51	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1520				
		100	1	51	Mo <sub>2</sub> Si <sub>3</sub>	630				
		100	2	115	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1310				
		1000	4	174	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1045				
		1100	4	127	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1145				
		1200	4	165	Mo <sub>2</sub> Si <sub>3</sub> , Mo <sub>2</sub> Si <sub>4</sub>	1070				
		700	4	0	Solid Solution	—				
		800	4	0	Titanium powder	—				
		800	2	60	—	650				
800	4	230	F <sub>2</sub> Si	610						
900	4	680	F <sub>2</sub> Si	645						
1000	4	180	F <sub>2</sub> Si	640						
1100	4	220	F <sub>2</sub> Si	890—1220						



Footnotes to table on page 4.

1  
1 Ratios  $\frac{n}{N}$  express approximately the degree of incompleteness of d-levels of atoms of transient metals : N-main quantum number, n-number of electrons on the incomplete d-level.

2 Piercing stress for coatings of identical thickness.

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